Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
10/765,693	CHEN, JIAN
Examiner	Art Unit
Andrew Q. Tran	2824

SEARCHED						
Class		Subclass	Date		Examiner	
365		185.02	9/24/2006		AT	
		185.03				Ī
		185.09				
		185.17				
		185.2				
		185.25				
		185.22				
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INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)					
	DATE	EXMR			
EAST/BRS	9/24/2006	AT			
Inventor & Assignee Search					
Forward & Backward Search					